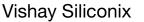
IRFD9024





HVMDIP

PRODUCT SUMMARY

V_{DS} (V)

 $\mathsf{R}_{\mathsf{DS}(\mathsf{on})}\left(\Omega\right)$

Q_{as} (nC)

Q_{gd} (nC)

Q_a (Max.) (nC)

Configuration

GC

P-Channel MOSFET

0.28

-60

19

5.4

11

Single

 $V_{GS} = -10 V$

Power MOSFET

FEATURES

- Dynamic dV/dt rating
- Repetitive avalanche rated
- For automatic insertion
- End stackable
- P-channel
- Fast switching
- 175 °C operating temperature
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain servers as a thermal link to the mounting surface for power dissipation levels up to 1 W.

ORDERING INFORMATION	
Package	HVMDIP
Lead (Pb)-free	IRFD9024PbF

ABSOLUTE MAXIMUM RATINGS (TA	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			V _{DS}	-60	- V	
Gate-source voltage			V _{GS}	± 20		
Continuous drain current	λ of 10 λ	T _A = 25 °C T _A = 100 °C	1	-1.6		
Continuous drain current	V_{GS} at -10 V $T_A = 20^{\circ} C$ I $T_A = 100^{\circ} C$		ID	-1.1	А	
Pulsed drain current ^a			I _{DM}	-13	1	
Linear derating factor				0.0083	W/°C	
Single pulse avalanche energy ^b			E _{AS}	140	mJ	
Repetitive avalanche current ^a			I _{AR}	-1.6	A	
Repetitive avalanche energy ^a			E _{AR}	0.13	mJ	
Maximum power dissipation $T_A = 25 \text{ °C}$		PD	1.3	W		
Peak diode recovery dv/dt ^c			dV/dt	-4.5	V/ns	
Operating junction and storage temperature range			T _J , T _{stg}	-55 to + 175	°C	
Soldering rRecommendations (peak temperature) ^d	Recommendations (peak temperature) d For 10 s			300 ^d		

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)

b. $V_{DD} = -25$ V, starting $T_J = 25$ °C, L = 15 mH, $R_a = 25 \Omega$, $I_{AS} = -3.2$ A (see fig. 12)

c. $I_{SD} \leq -11$ A, dl/dt ≤ 140 A/µs, $V_{DD} \leq V_{DS}$, $T_J \leq 175$ °C

d. 1.6 mm from case



COMPLIANT



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	120	°C/W	

PARAMETER	SYMBOL	TES	T CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	: 0 V, I _D = -250 μA	-60	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Referenc	e to 25 °C, I _D = -1 mA	-	-0.056	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	V_{GS} , I_D = -250 μ A	-2.0	-	-4.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 V	-	-	± 100	nA
		$V_{DS} = -60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	-	-100	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = -48 V	, V _{GS} = 0 V, T _J = 150 °C	-	-	-500	μA
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = -10 V$	I _D = -0.96 A ^b	-	-	0.28	Ω
Forward Transconductance	g fs	V _{DS} = ·	V _{DS} = -25 V, I _D = -0.96 A ^b		-	-	S
Dynamic							
Input Capacitance	C _{iss}	V _{GS} = 0 V		-	570	-	pF
Output Capacitance	C _{oss}		$V_{DS} = -25 V$		360	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	65	-	
Total Gate Charge	Qg			-	-	19	
Gate-Source Charge	Q _{gs}	$V_{GS} = -10 V$	I _D = -11 A, V _{DS} = -48 V see fig. 6 and 13 ^b	-	-	5.4	nC
Gate-Drain Charge	Q _{gd}	_		-	-	11	
Turn-On Delay Time	t _{d(on)}			-	13	-	
Rise Time	t _r	V _{DD} =	V _{DD} = -30 V, I _D = -11 A		68	-	- ns
Turn-Off Delay Time	t _{d(off)}	$R_g = 18 \Omega$, $R_D = 2.5 \Omega$, see fig. 10^{b}		-	15	-	
Fall Time	t _f				29	-	
Internal Drain Inductance	L _D	6 mm (0.25") f	Between lead, 6 mm (0.25") from		4.0	-	nH
Internal Source Inductance	L _S	die contact		-	6.0	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	-	-1.6	Α
Pulsed Diode Forward Current ^a	I _{SM}	integral revers p - n junction		-	-	-13	
Body Diode Voltage	V _{SD}	T _J = 25 °C	$I_{\rm S}$ = -1.6 A, $V_{\rm GS}$ = 0 V ^b	-	-	-6.3	V
Body Diode Reverse Recovery Time	t _{rr}			-	100	200	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$I_{\rm J} = 25 {}^{\circ}{\rm C}, I_{\rm F}$	= -11 A, dl/dt = 100 A/µs ^b	-	0.32	0.64	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	rn-on time is negligible (turn	-on is dor	ninated b	y L _S and	L _D)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)

b. Pulse width \leq 300 µs; duty cycle \leq 2 %

2



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

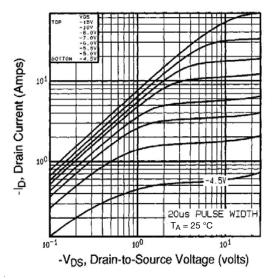


Fig. 1 - Typical Output Characteristics, $T_A = 25 \ ^{\circ}C$

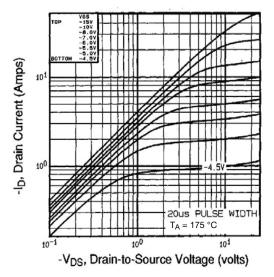


Fig. 1 - Typical Output Characteristics, $T_A = 175 \ ^{\circ}C$

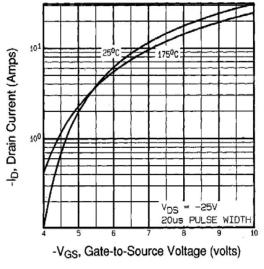


Fig. 2 - Typical Transfer Characteristics

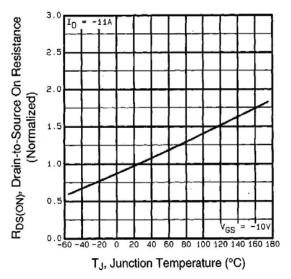


Fig. 3 - Normalized On-Resistance vs. Temperature

3



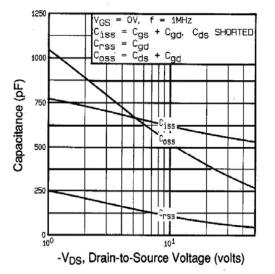


Fig. 4 - Typical Capacitance vs. Drain-to-Source Voltage

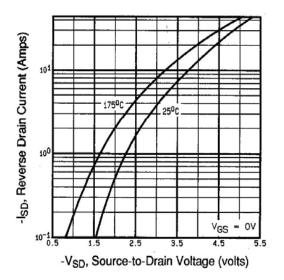


Fig. 6 - Typical Source-Drain Diode Forward Voltage

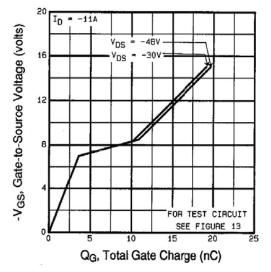


Fig. 5 - Typical Gate Charge vs. Gate-to-Source Voltage

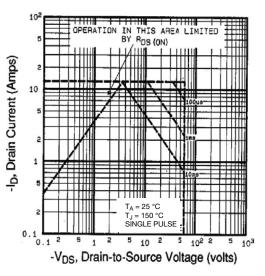


Fig. 7 - Maximum Safe Operating Area

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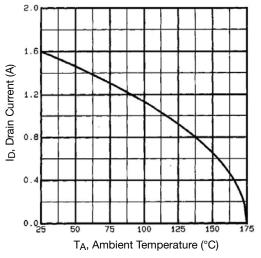


Fig. 8 - Maximum Drain Current vs. Ambient Temperature

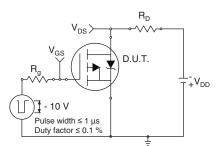


Fig. 10a - Switching Time Test Circuit

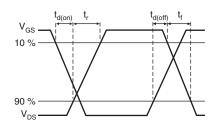


Fig. 10b - Switching Time Waveforms

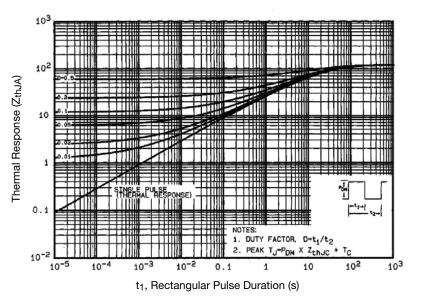


Fig. 9 - Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



IRFD9024

Vishay Siliconix

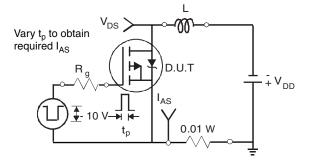


Fig. 12a - Unclamped Inductive Test Circuit

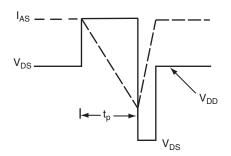


Fig. 12b - Unclamped Inductive Waveforms

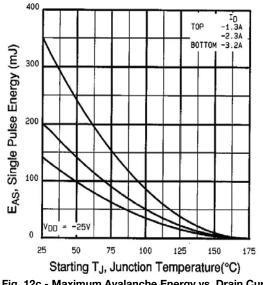
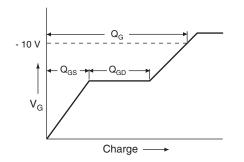


Fig. 12c - Maximum Avalanche Energy vs. Drain Current





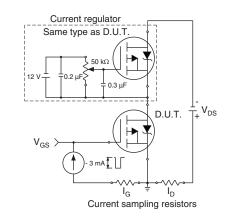


Fig. 13b - Gate Charge Test Circuit

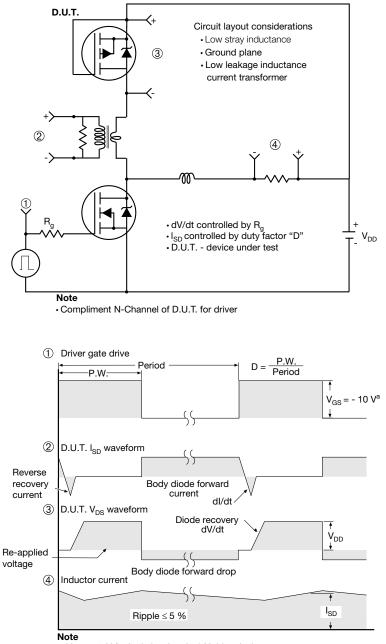
6

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Peak Diode Recovery dV/dt Test Circuit



a. V_{GS} = - 5 V for logic level and - 3 V drive devices



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HVM DIP (High voltage)





	INCHES		MILLIN	IETERS
DIM.	MIN.	MAX.	MIN.	MAX.
А	0.310	0.330	7.87	8.38
E	0.300	0.425	7.62	10.79
L	0.270	0.290	6.86	7.36
ECN: X10-0386-Rev. B, 0 DWG: 5974	06-Sep-10			

Note

1. Package length does not include mold flash, protrusions or gate burrs. Package width does not include interlead flash or protrusions.



Vishay

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